

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/770,148	HUBER ET AL.	
Examiner	Art Unit	
David E. Martinez	2181	

SEARCHED						
Class	Subclass	Date	Examiner			
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
710	72,62,303	11/20/2006	DM			
361	686	11/20/2006	DM			
Databases: US Patents, US PGPUBS, USOCR, EPO, Derwent,		11/20/2006	DM			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East see attached	11/20/2006	DM		
eDan inventor search	11/20/2006	DM		
Databases: US Patents, US PGPUBS, USOCR, EPO, Derwent, IBM_TDB.	11/20/2006	DM		
710/62,72,300,303,304.ccls. 361/679,681,682,686.ccls. with keywords and text search	11/20/2006	DΜ		
Lea-Edmonds, Lisa from Class 361	11/20/2006	DM		
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